Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,053	ICHIKAWA ET AL.	
Examiner	Art Unit	
Richard Hanig	2873	

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Class	Subclass	Date	Examiner
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385	2		
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372	102		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
D. Spector	4/21/09	AH	
359/321,322,323			
385/2,8			
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